Application/Control No. Applicant(s)/Patent Under Reexamination 10/807,695 NILFORUSHAN, ALI Notice of References Cited Examiner Art Unit Page 1 of 2 Son T. Nguyen 3643 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Name Classification MM-YYYY US-5,537,954 07-1996 Α Beeghly et al. 119/850 US-6,267,083 В 07-2001 Chimienti, Pat 119/850 07-1992 С US-5,127,213 Petronio, Mark 54/71 D US-US-Ε F US-G US-US-Н US-1 J US-Κ US-1 US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Country Code-Number-Kind Code MM-YYYY Classification Ν DE 20021260 U1 -03-2001 Germany UHR A01K 13/00 GB 2374535 A 10-2002 **United Kingdom** WILSON, BEVERLEY A61F 07/00 Ρ DE 20204836 U1 📝 08-2002 Germany **OREILLY** A01K 13/00 Q CH605400 -09-1978 **SWITZERLAND GAMBETTA** B68C 5/00 R DE 10213615 A1 10-2003 Germany O'REILLY, DETLEV A01K 13/00 S DE 4140507 A1 04-1993 SCHULTE, ERICH Germany A01K 13/00 JP10113088 05-1998 **JAPAN** TADAUCHI ET AL. A01K 13/00 **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) u

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Application/Control No. Applicant(s)/Patent Under Reexamination 10/807,695 NILFORUSHAN, ALI Notice of References Cited Examiner Art Unit Page 2 of 2 Son T. Nguyen 3643 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-С US-US-D US-Ε US-F US-G US-UŞ-1 J US-Κ US-Ļ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Code-Number-Kind Code Country MM-YYYY Name Classification Ν WO03/043413A1 05-2003 **WIPO MacGUINNESS** A01K 13/00 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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